

## **BSI Standards Publication**

Fine ceramics (advanced ceramics, advanced technical ceramics) — Test method for crystalline quality of single-crystal thin film (wafer) using XRD method with parallel X-ray beam



BS ISO 22278:2020 BRITISH STANDARD

## **National foreword**

This British Standard is the UK implementation of ISO 22278:2020.

The UK participation in its preparation was entrusted to Technical Committee RPI/13, Advanced technical ceramics.

A list of organizations represented on this committee can be obtained on request to its committee manager.

This publication does not purport to include all the necessary provisions of a contract. Users are responsible for its correct application.

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